


<b>Search Notes</b>  	<b>Application/Control No.</b>  10772750	<b>Applicant(s)/Patent Under Reexamination</b>  YAMADA ET AL.
	<b>Examiner</b>  Geib, Benjamin	<b>Art Unit</b>  2181

SEARCHED			
Class	Subclass	Date	Examiner
712	200	2/26/2010	BPG

SEARCH NOTES		
Search Notes	Date	Examiner
Updated EAST Search	2/26/2010	BPG
Inventor Name search	2/26/2010	BPG
NPL search (Google Scholar and IEEE Xplore)	2/26/2010	BPG

INTERFERENCE SEARCH			
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